Probes and Test Fixtures for Lead Components


Test Fixtures for SMD


## DC Bias Unit

DC BIAS VOLTAGE UNIT 9268-10
Direct connection type, 40 Hz to 5 MHz , maximum applied voltage of $\mathrm{DC} \pm 40 \mathrm{~V}$.
*When using the DC Bias Unit, external constant-voltage and constant-current sources are required.

| HIOKI LCR Fixtures and Probes |  |  | 3506-10 | 3504 S | 3511-50 | 3532-50 | 3535 | IM3523 | IM3533 | IM3533-01 | IM3570 | IM3590 |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  |  | C | C | LCR | LCR | LCR | LCR | LCR | LCR | LCR | LCR |
|  |  |  | $1 \mathrm{kHz}, 1 \mathrm{MHz}$ | $120 \mathrm{~Hz}, 1 \mathrm{kHz}$ | $120 \mathrm{~Hz}, 1 \mathrm{kHz}$ | $\begin{gathered} 42 \mathrm{~Hz} \text { to } \\ 5 \mathrm{MHz} \\ \hline \end{gathered}$ | $\begin{aligned} & 100 \mathrm{kHz} \text { to } \\ & 120 \mathrm{MHz} \\ & \hline \end{aligned}$ | $\begin{aligned} & 40 \mathrm{~Hz} \text { to } \\ & 200 \mathrm{kHz} \end{aligned}$ | $\begin{aligned} & 1 \mathrm{mHz} \text { to } \\ & 200 \mathrm{kHz} \end{aligned}$ | $\begin{aligned} & 1 \mathrm{mHz} \text { to } \\ & 200 \mathrm{kHz} \end{aligned}$ | 4 Hz to 5 MHz | $\begin{aligned} & 1 \mathrm{mHz} \text { to } \\ & 200 \mathrm{kHz} \end{aligned}$ |
| 9143 | Pin Type Probe | DC to $5 \mathrm{MHz}, 75 \Omega$ |  | $\checkmark$ | $\checkmark$ | $\checkmark$ |  |  |  |  |  |  |
| 9140 | 4-Terminal Probe | DC to $100 \mathrm{kHz}, 75 \Omega$ |  | $\checkmark$ | $\checkmark$ | $\checkmark$ |  |  |  |  |  |  |
| 9261-10 | Test Fixture | DC to $5 \mathrm{MHz}, 50 \Omega$ | $\checkmark$ |  |  |  |  | $\checkmark$ | $\checkmark$ | $\checkmark$ | $\checkmark$ | $\checkmark$ |
| 9143-10 | Pin Type Probe | DC to $5 \mathrm{MHz}, 50 \Omega$ | $\checkmark$ |  |  |  |  | $\checkmark$ | $\checkmark$ | $\checkmark$ | $\checkmark$ | $\checkmark$ |
| 9140-10 | 4-Terminal Probe | DC to $200 \mathrm{kHz}, 50 \Omega$ | $\checkmark$ |  |  |  |  | $\checkmark$ | $\checkmark$ | $\checkmark$ | $\checkmark$ | $\checkmark$ |
| L2000 | 4-Terminal Probe | DC to $5 \mathrm{MHz}, 50 \Omega$ | $\checkmark$ |  |  |  |  | $\checkmark$ | $\checkmark$ | $\checkmark$ | $\checkmark$ | $\checkmark$ |
| 9261 | Test Fixture | DC to $5 \mathrm{MHz}, 75 \Omega$ |  | $\checkmark$ | $\checkmark$ | $\checkmark$ |  |  |  |  |  |  |
| 9262 | Test Fixture | DC to 5MHz | $\checkmark$ | $\checkmark$ | $\checkmark$ | $\checkmark$ |  | $\checkmark$ | $\checkmark$ | $\checkmark$ | $\checkmark$ | $\checkmark$ |
| 9263 | SMD Test Fixture | DC to 5MHz | $\checkmark$ | $\checkmark$ | $\checkmark$ | $\checkmark$ |  | $\checkmark$ | $\checkmark$ | $\checkmark$ | $\checkmark$ | $\checkmark$ |
| 9677 | SMD Test Fixture | DC to 120 MHz | $\checkmark$ | $\checkmark$ | $\checkmark$ | $\checkmark$ | $\checkmark$ | $\checkmark$ | $\checkmark$ | $\checkmark$ | $\checkmark$ | $\checkmark$ |
| 9699 | SMD Test Fixture | DC to 120 MHz | $\checkmark$ | $\checkmark$ | $\checkmark$ | $\checkmark$ | $\checkmark$ | $\checkmark$ | $\checkmark$ | $\checkmark$ | $\checkmark$ | $\checkmark$ |
| 9268 | DC Bias Voltage Unit | 42 Hz to 5 MHz |  |  | $\checkmark^{*}$ | $\checkmark^{*}$ |  |  |  |  |  |  |
| 9268-01 | DC Bias Voltage Unit | 42 Hz to 5 MHz |  |  |  | $\boldsymbol{\nu}$ * |  |  |  |  |  |  |
| 9268-10 | DC Bias Voltage Unit | 40 Hz to 5 MHz |  |  |  |  |  | $\boldsymbol{V}^{*}$ | $\boldsymbol{V}^{*}$ | $\boldsymbol{V}^{*}$ | $\boldsymbol{V}^{*}$ | $\boldsymbol{V}^{*}$ |
| 9269 | DC Bias Current Unit | 42 Hz to 100 kHz |  |  | $\boldsymbol{V}^{*}$ | $\boldsymbol{V}^{*}$ |  |  |  |  |  |  |
| 9269-10 | DC Bias Current Unit | 40 Hz to 2 MHz |  |  |  |  |  | $\checkmark^{*}$ | $\checkmark^{*}$ | $\checkmark^{*}$ | $\checkmark$ * | $\checkmark^{*}$ |
| 9500-10 | 4-Terminal Probe | DC to $200 \mathrm{kHz}, 50 \Omega$ | $\checkmark$ |  |  |  |  | $\checkmark$ | $\checkmark$ | $\checkmark$ | $\checkmark$ | $\checkmark$ |

*External voltage or current power supply required

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